# **Power MOSFET**

# -20 V, -5.8 A, Single P-Channel, TSOP-6

#### **Features**

- Low R<sub>DS(on)</sub> in TSOP-6 Package
- 1.8 V Gate Rating
- Fast Switching
- This is a Pb-Free Device

### **Applications**

- Optimized for Battery and Load Management Applications in Portable Equipment
- High Side Load Switch
- Switching Circuits for Game Consoles, Camera Phone, etc.

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

,						
Param	Symbol	Value	Unit			
Drain-to-Source Voltag	$V_{DSS}$	-20	V			
Gate-to-Source Voltage	<b>9</b>		$V_{GS}$	±8.0	V	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	-5.1	А	
Current (Note 1)	State	T <sub>A</sub> = 85°C	]	-3.6		
	t ≤ 5 s	T <sub>A</sub> = 25°C	1	-5.8		
Power Dissipation	Steady		$P_{D}$	1.25		
(Note 1)	State	T <sub>A</sub> = 25°C			W	
	t ≤ 5 s			1.6		
Continuous Drain	Steady	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	-3.7	_	
Current (Note 2)		T <sub>A</sub> = 85°C		-2.7	Α	
Power Dissipation (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.7	W	
Pulsed Drain Current	t <sub>p</sub> = 10 μ	S	I <sub>DM</sub>	-20	Α	
Operating Junction and	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C			
Lead Temperature for S (1/8" from case for 10 s)	TL	260	°C			

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
- Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0775 in sq).

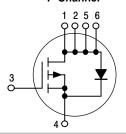


# ON Semiconductor®

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX		
-20 V	25 mΩ @ -4.5 V	-5.1 A		
	32 mΩ @ -2.5 V	-4.5 A		
	41 mΩ @ -1.8 V	-2.5 A		

# P-Channel



# MARKING DIAGRAM



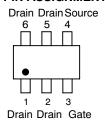
TSOP-6 CASE 318G STYLE 1



SD = Device Code M = Date Code ■ Pb-Free Package

(Note: Microdot may be in either location)

### **PIN ASSIGNMENT**



# **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>		
NTGS3136PT	TSOP-6 (Pb-Free)	3000 / Tape & Reel		

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NTGS3136P

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	100	
Junction-to-Ambient – t = 5 s (Note 3)	$R_{ hetaJA}$	77	°C/W
Junction-to-Ambient – Steady State (Note 4)	$R_{ hetaJA}$	185	

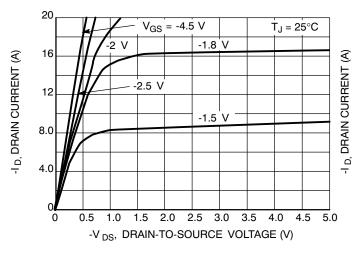
<sup>3.</sup> Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
4. Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0775 in sq).

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu A$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	ID = -250 μA, Reference 25°C			-13		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub> V <sub>GS</sub> = 0 V. T <sub>J</sub> = 25°C		T <sub>J</sub> = 25°C			-1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = -20 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 85^{\circ}\text{C}$				-5.0	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±8.0 V			±0.1	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	-250 μA	-0.4		-1.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$R_{DS(on)}$ $V_{GS} = -4.5 \text{ V}, I_D = -5.1 \text{ A}$			25	33	mΩ
		V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = -4.5 A			32	40	
		V <sub>GS</sub> = -1.8 V, I <sub>D</sub> = -2.5 A			41	51	1
Forward Transconductance	9FS	V <sub>DS</sub> = -5.0 V, I <sub>D</sub>	= -5.1 A		22		S
CHARGES, CAPACITANCES AND GATE RES	ISTANCE				•	•	
Input Capacitance	C <sub>ISS</sub>				1901		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, } V_{DS} = -10 \text{ V}$			274		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				175		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V};$ $I_{D} = -5.1 \text{ A}$			18	29	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.7		1
Gate-to-Source Charge	Q <sub>GS</sub>				2.4		
Gate-to-Drain Charge	$Q_{GD}$				4.3		
Gate Resistance	$R_{G}$				7.6		Ω
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t <sub>d(ON)</sub>				9	19	ns
Rise Time	T <sub>r</sub>	$V_{GS}$ = *4.5 V, $V_{DD}$ = -10 V, $I_{D}$ = -1.0 A, $R_{G}$ = 6.0 $\Omega$			9	19	
Turn-Off Delay Time	t <sub>d(OFF)</sub>				99	160	1
Fall Time	T <sub>f</sub>				48	79	1
DRAIN-SOURCE DIODE CHARACTERISTICS				-	-	-	-
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		-0.7	-1.2	V
		$I_S = -1.7 \text{ A}$ $T_J =$			-0.6		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}, d_{1S}/d_{t} = 100 \text{ A/}\mu\text{s}, \\ I_{S} = -1.7 \text{ A}$			37	60	ns

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%
6. Switching characteristics are independent of operating junction temperatures

# 查询"NTGS3136P-D"供应向 PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



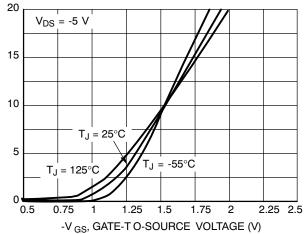
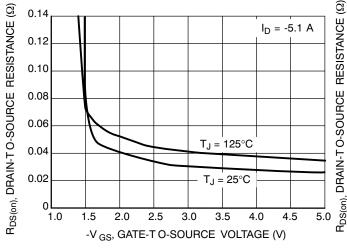


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



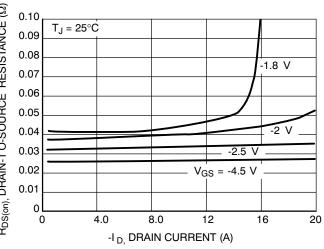
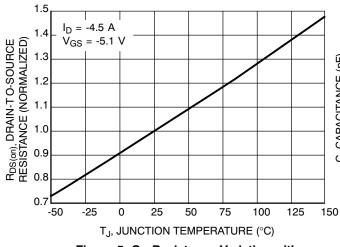


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



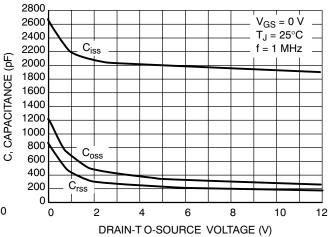


Figure 5. On-Resistance Variation with Temperature

Figure 6. Capacitance Variation

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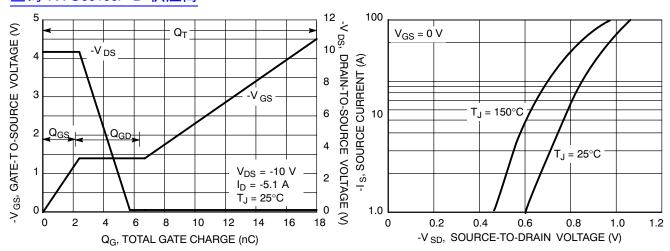


Figure 7. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

Figure 8. Diode Forward Voltage vs. Current

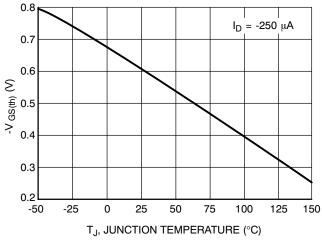


Figure 9. Threshold Voltage

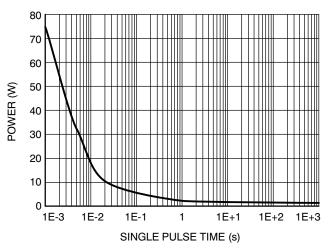


Figure 10. Single Pulse Maximum Power Dissipation

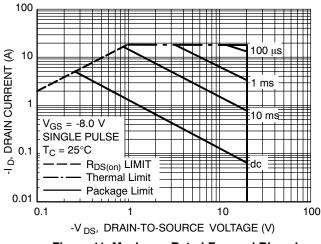


Figure 11. Maximum Rated Forward Biased Safe Operating Area

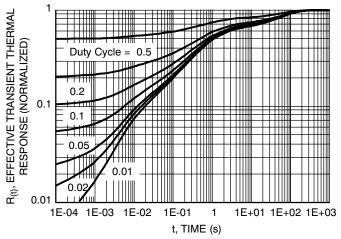


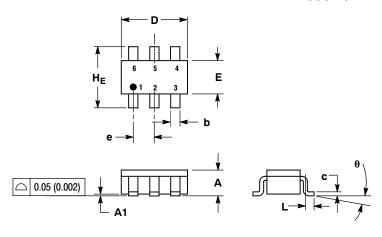
Figure 12. FET Thermal Response

# NTGS3136P

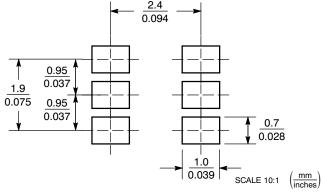
# 查询"NTGS3136P-D"供应商

### PACKAGE DIMENSIONS

# TSOP-6 CASE 318G-02 ISSUE S



# **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
  MAXIMUM LEAD THICKNESS INCLUDES LEAD
  FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL
- DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.90	1.00	1.10	0.035	0.039	0.043
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.25	0.38	0.50	0.010	0.014	0.020
С	0.10	0.18	0.26	0.004	0.007	0.010
D	2.90	3.00	3.10	0.114	0.118	0.122
E	1.30	1.50	1.70	0.051	0.059	0.067
е	0.85	0.95	1.05	0.034	0.037	0.041
L	0.20	0.40	0.60	0.008	0.016	0.024
HE	2.50	2.75	3.00	0.099	0.108	0.118
θ	0°	-	10°	0°	-	10°

# STYLE 1: PIN 1. DRAIN

- - 2. DRAIN 3. GATE
- SOURCE
- DRAIN

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